Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,870	BEYER ET AL.
Examiner	Art Unit
Emeka Ebirim	2166

SEARCHED				
Class	Subclass	Date	Examiner	
707	1-10	5/26/2006	EE	
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			,	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH) .
	DATE	EXMR
EAST search	5/26/2006	EE
Consulted Mohammad Ali (primary)	5/26/2006	EE .
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Consulted Pham Khanh (primary)	5/24/2006	EE